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S72NS-P Based MCPs/PoPs

MirrorBit[™] Flash Memory and DRAM 128/256/512 Mb (8/16/32 M x 16 bit), 1.8 Volt-only, Multiplexed Simultaneous Read/Write, Burst Mode Flash Memory 128/256 Mb (8/16 M x 16 bit) DDR DRAM on Split Bus



Data Sheet (Advance Information)

Notice to Readers: This document states the current technical specifications regarding the Spansion product(s) described herein. Each product described herein may be designated as Advance Information, Preliminary, or Full Production. See *Notice On Data Sheet Designations* for definitions.



Notice On Data Sheet Designations

Spansion Inc. issues data sheets with Advance Information or Preliminary designations to advise readers of product information or intended specifications throughout the product life cycle, including development, qualification, initial production, and full production. In all cases, however, readers are encouraged to verify that they have the latest information before finalizing their design. The following descriptions of Spansion data sheet designations are presented here to highlight their presence and definitions.

Advance Information

The Advance Information designation indicates that Spansion Inc. is developing one or more specific products, but has not committed any design to production. Information presented in a document with this designation is likely to change, and in some cases, development on the product may discontinue. Spansion Inc. therefore places the following conditions upon Advance Information content:

"This document contains information on one or more products under development at Spansion Inc. The information is intended to help you evaluate this product. Do not design in this product without contacting the factory. Spansion Inc. reserves the right to change or discontinue work on this proposed product without notice."

Preliminary

The Preliminary designation indicates that the product development has progressed such that a commitment to production has taken place. This designation covers several aspects of the product life cycle, including product qualification, initial production, and the subsequent phases in the manufacturing process that occur before full production is achieved. Changes to the technical specifications presented in a Preliminary document should be expected while keeping these aspects of production under consideration. Spansion places the following conditions upon Preliminary content:

"This document states the current technical specifications regarding the Spansion product(s) described herein. The Preliminary status of this document indicates that product qualification has been completed, and that initial production has begun. Due to the phases of the manufacturing process that require maintaining efficiency and quality, this document may be revised by subsequent versions or modifications due to changes in technical specifications."

Combination

Some data sheets contain a combination of products with different designations (Advance Information, Preliminary, or Full Production). This type of document distinguishes these products and their designations wherever necessary, typically on the first page, the ordering information page, and pages with the DC Characteristics table and the AC Erase and Program table (in the table notes). The disclaimer on the first page refers the reader to the notice on this page.

Full Production (No Designation on Document)

When a product has been in production for a period of time such that no changes or only nominal changes are expected, the Preliminary designation is removed from the data sheet. Nominal changes may include those affecting the number of ordering part numbers available, such as the addition or deletion of a speed option, temperature range, package type, or V_{IO} range. Changes may also include those needed to clarify a description or to correct a typographical error or incorrect specification. Spansion Inc. applies the following conditions to documents in this category:

"This document states the current technical specifications regarding the Spansion product(s) described herein. Spansion Inc. deems the products to have been in sufficient production volume such that subsequent versions of this document are not expected to change. However, typographical or specification corrections, or modifications to the valid combinations offered may occur."

Questions regarding these document designations may be directed to your local Spansion sales office.

S72NS-P Based MCPs/PoPs

MirrorBit[™] Flash Memory and DRAM 128/256/512 Mb (8/16/32 M x 16 bit), 1.8 Volt-only, Multiplexed Simultaneous Read/Write, Burst Mode Flash Memory 128/256 Mb (8/16 M x 16 bit) DDR DRAM on Split Bus



Data Sheet (Advance Information)

Features

- Power supply voltage of 1.7 V to 1.95 V
- Burst Speeds
 - Flash = 66 MHz, 80 MHz
 - DRAM = 133 MHz

- Packages
 - 11.0 x 10.0 mm, 133-ball MCP
 - 8.0 x 8.0 mm, 133-ball MCP
 - 12.0 x 12.0 mm, 128-ball PoP
- Operating Temperature of -25°C to +85°C

General Description

This document contains information on the S72NS-P MCP stacked products. Refer to the S29NS-P data sheet (S29NS-P_00) for full electrical specifications of the Flash memory component.

The S72NS Series is a product line of stacked products (MCPs and PoPs), and consists of:

- NS family multiplexed Flash memory die
- DDR DRAM

The products covered by this document are listed in the tables below.

	DRAM Density			
Flash Density	128 Mb	256 Mb		
128 Mb	S72NS128PD0			
256 Mb	S72NS256PD0			
512 Mb	S72NS512PD0	S72NS512PE0		

For detailed specifications, please refer to the individual data sheets.

Density	Manufacturer	Publication Number
128	DRAM1	SDRAM_03
120	DRAM5	SDRAM_07

Density	Manufacturer	Publication Number
256	DRAM1	TBD
250	DRAM5	SDRAM_11

Publication Number S72NS-P 00

Revision 01

Issue Date September 6, 2006

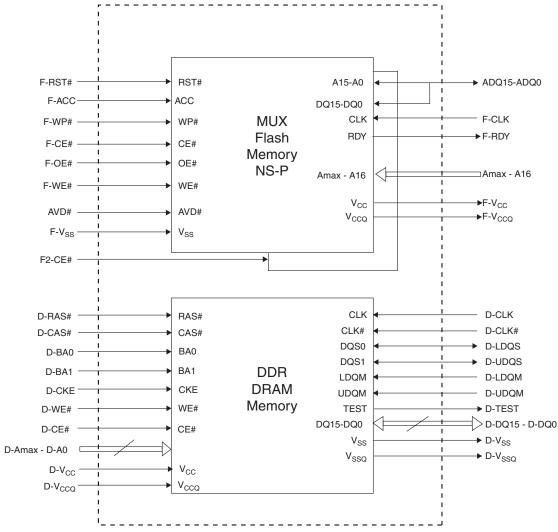


1. Product Selector Guide

Device OPN	Flash Density	DDR DRAM Density	Flash Speed (MHz)	DDR DRAM Speed (MHz)	Supplier	Package
S72NS128PD0AJBGG			66		DDAMA	
S72NS128PD0AJBGC		400 141	80	133	DRAM1	8.0 x 8.0mm133-ball MCP
S72NS128PD0AJBLG	128 Mb	128 Mb	66	133	DDAME	8.0 x 8.0mm133-ball MCP
S72NS128PD0AJBLC			80		DRAM5	
S72NS128PD0KJFGG			66		DRAM1	
S72NS128PD0KJFGC	128 Mb	128 Mb	80	133	DHAIVIT	12.0 x 12.0mm 128-ball PoP
S72NS128PD0KJFLG	120 1010	120 1/10	66	133	DRAM5	12.0 X 12.0111111 120-Dali FOF
S72NS128PD0KJFLC			80		DHAND	
S72NS256PD0AJBGG			66		DRAM1	
S72NS256PD0AJBGC	256 Mb	128 Mb	80	133	DRAWII	8.0 x 8.0mm133-ball MCP
S72NS256PD0AJBLG	256 IVID	120 1/10	66	DRAM5	6.0 x 6.011111133-Dali MCF	
S72NS256PD0AJBLC			80		DRANS	
S72NS256PD0KJFGG			66		DRAM1	
S72NS256PD0KJFGC	OFC Mb	128 Mb	80	133	DHAIVIT	12.0 x 12.0mm 128-ball PoP
S72NS256PD0KJFLG	256 Mb	128 MD	66		DRAM5	
S72NS256PD0KJFLC			80			
S72NS512PD0AJGGG			66		DRAM1	
S72NS512PD0AJGGC	512 Mb	128 Mb	80	100	DRAWII	11 0 v 10 0mm 100 hall MCD
S72NS512PD0AJGLG	512 IVID	128 1/10	66	133	DDAME	11.0 x 10.0mm 133-ball MCP
S72NS512PD0AJGLC			80		DRAM5	
S72NS512PD0KJFGG			66		DDAM1	
S72NS512PD0KJFGC	510 Mb	100 Mb	80	100	DRAM1	10.0 v 10.0mm 100 hall DaD
S72NS512PD0KJFLG	512 Mb	128 Mb	66	133		12.0 x 12.0mm 128-ball PoP
S72NS512PD0KJFLC			80		DRAM5	
S72NS512PE0AJGGG			66		DDAMA	
S72NS512PE0AJGGC	510 Mb	OEC Mb	80	100	DRAM1	11.0 x 10.0mm 133-ball MCP
S72NS512PE0AJGLG	512 Mb	256 Mb	66	133		
S72NS512PE0AJGLC			80		DRAM5	
S72NS512PE0KJFGG			66		DDAM4	
S72NS512PE0KJFGC	510 Mb	050 Mb	80	100	DRAM1	10.0 v 10.0 mm 100 hall D-D
S72NS512PE0KJFLG	215 IMD	512 Mb 256 Mb	66	133	DDAME	12.0 x 12.0mm 128-ball PoP
S72NS512PE0KJFLC			80		DRAM5	



2. Product Block Diagram



Notes:

- 1. Amax indicates highest address bit for memory component:
 - a. Amax = A24 for NS512P, A23 for NS256P, A22 for NS128P
 - b. Amax = A11 for 128 Mb DDR DRAM
 - c. Amax = A12 for 256Mb DDR DRAM
- 2. For Flash, A15 A0 is tied to DQ15 DQ0.



3. Connection Diagrams

Figure 3.1 133-ball Fine-Pitch Ball Grid Array MCP

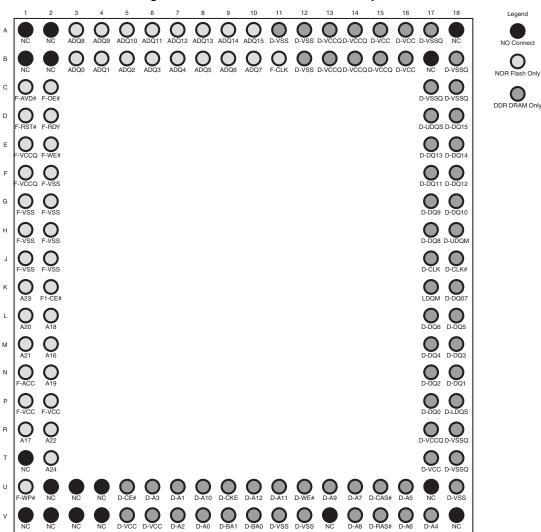
Note:

Additional NC locations are in reference to the superset connection diagram shown here

Device OPN	Flash Address Amax	DDR DRAM Address Amax	Additional NC Locations
S72NS128PD0	A22	A11	Ball F1, Ball E1, Ball N11
S72NS256PD0	A23	A11	Ball E1, Ball N11
S72NS512PD0	A24	A11	Ball N11
S72NS512PE0	A24	A12	N/A



Figure 3.2 128-ball Fine-Pitch Ball Grid Array, PoP



Note:

Additional NC locations are in reference to the superset connection diagram shown here.

Device OPN	Flash Address Amax	DDR DRAM Address Amax	Additional NC Locations
S72NS128PD0	A22	A11	Ball K1, Ball T2, Ball U10
S72NS256PD0	A23	A11	Ball K1, Ball U10
S72NS512PD0	A24	A11	Ball U10
S72NS512PE0	A24	A12	N/A



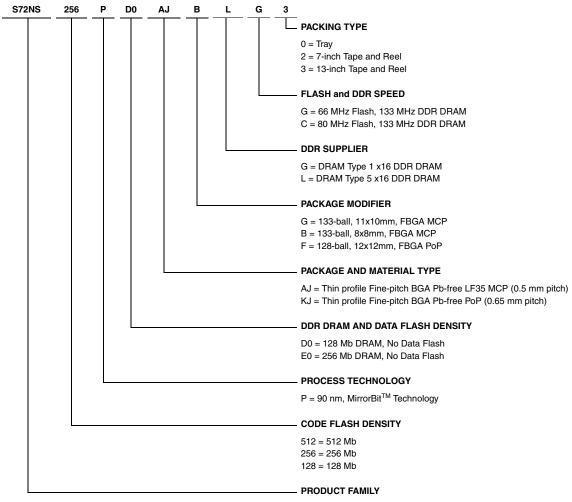
4. Input/Output Descriptions

Signal		Description	Flash	DRAM
Amax – A16	=	Flash Address inputs		
ADQ15 – ADQ0	=	Flash multiplexed Address and Data		
F-CE#	=	Flash Chip-enable input. Asynchronous relative to CLK for Burst Mode	Х	
F-OE#	=	Flash Output Enable input. Asynchronous relative to CLK for Burst mode.	Х	
F-WE#	=	Flash Write Enable input	Х	
F-VCC	=	Flash device power supply (1.7 V to 1.95 V)	Х	
F-VCCQ	=	Flash Input/Output Buffer power supply	Х	
F-VSS	=	Flash Ground	Х	
F-RDY	=	Flash ready output. Indicates the status of the Burst read. V_{OL} = data invalid. V_{OH} = data valid.	Х	
F-CLK	=	Flash Clock. The first rising edge of CLK in conjunction with AVD# low latches the address input and activates burst mode operation. After the initial word is output, subsequent rising edges of CLK increment the internal address counter. CLK should remain low during asynchronous access.	Х	
F-AVD#	=	Flash Address Valid input. Indicates to device that the valid address is present on the address inputs. V_{IL} = for asynchronous mode, indicates valid address; for burst mode, causes starting address to be latched on rising edge of CLK. V_{IH} = device ignores address inputs	х	
F-RST#	=	Flash hardware reset input. V _{IL} = device resets and returns to reading array data	Х	
F-WP#	=	Flash hardware write protect input. V_{IL} = disables program and erase functions in the four outermost sectors	Х	
F-ACC	=	Flash accelerated input. At V_{HH} , accelerates programming; automatically places device in unlock bypass mode. At V_{IL} , disables all program and erase functions. Should be at V_{IH} for all other conditions.	Х	
D-A12 – D-A0	=	DRAM Address inputs.		Х
D-DQ15 – D-DQ0	=	DRAM Data input/output		Х
D-CLK	=	DRAM System Clock		Х
D-CE#	=	DRAM Chip Select		Х
D-CKE	=	DRAM Clock Enable		Х
D-BA1 – BA0	=	DRAM Bank Select		Х
D-RAS#	=	DRAM Row Address Strobe		Х
D-CAS#	=	DRAM Column Address Strobe		Х
D-UDQM – D-LDQM	=	DRAM Data Input Mask		Х
D-WE#	=	DRAM Write Enable input		Х
D-VSS	=	DRAM Ground		Х
D-VSSQ	=	DRAM Input/Output Buffer ground		Х
D-VCCQ	=	DRAM Input/Output Buffer power supply		Х
D-VCC	=	DRAM device power supply		Х
D-UDQS	=	DRAM Upper Data Strobe, output with read data and input with write data		Х
D-LDQS	=	DRAM Lower Data Strobe, output with read data and input with write data		Х
D-CLK#	=	DDR Clock for negative edge of CLK		Х
RFU	=	Reserved for Future Use		
NC	=	No Connect. Can be connected to ground or left floating.		
DNU	=	Do Not Use. This signal must be left floating		



5. Ordering Information

The order number (Valid Combination) is formed by the following:



S72NS Multi-Chip Product (MCP)

1.8 V Multiplexed, SRW, Burst Mode Flash and DDR DRAM on Split Bus

	Valid Combinations								
Product Family	Code Flash Density (Mb)	Process Technology	DRAM Density (Mb)	Package Type/ Material	DDR Vendor	Flash & DDR Speed	Packing Type		
	128		D0	Do	DO	AJB, KJF		G, C	
S72NS	256	Р		AJB, NJF	G, L	G. C	0, 2, 3 (Note 1)		
	512		D0, E0	AJG, KJF		G, C	(14010-1)		

Notes:

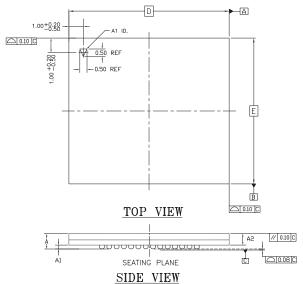
- 1. Packing Type 0 is standard. Specify other options as required.
- 2. BGA package marking omits leading "S" and packing type designator from ordering part number.
- Valid Combinations list configurations planned to be supported in volume for this device. Consult your local sales office to confirm availability of specific valid combinations and to check on newly released combinations.

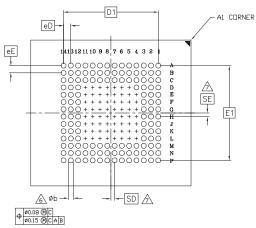


6. Physical Dimensions

PACKAGE

6.1 NLC133—133-ball Fine-Pitch Ball Grid Array (FBGA) 11.0 x 10.0 mm





BOTTOM VIEW

PACKAGE		NLC 133		
JEDEC	N/A			
DxE	11.0 mm x 10.00 mm PACKAGE			
SYMBOL	MIN	NOM	MAX	NOTE
Α	0.90	1.00	1.10	PROFILE
A1	0.20	0.25	0.30	BALL HEIGHT
A2	0.70	0.76	0.82	BODY THICKNESS
D	10.9	11.0	11.1	BODY SIZE
E	9.9	9.9 10.0 10.1		BODY SIZE
D1		6.50 BSC.		MATRIX FOOTPRINT
E1		6.50 BSC.		MATRIX FOOTPRINT
MD		14		MATRIX SIZE D DIRECTION
ME		14		MATRIX SIZE E DIRECTION
n		133		BALL COUNT
Øb	0.25	0.30	0.35	BALL DIAMETER
eЕ		0.50 BSC.		BALL PITCH
eD		0.50 BSC		BALL PITCH
SD / SE	0.25 BSC.			SOLDER BALL PLACEMENT
	G4-G	11, E4-E11, F 11, H4-H11, ‹ (4-K11, L4-L1	J4-J11	DEPOPULATED SOLDER BALLS

NI C 133

NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- 3. BALL POSITION DESIGNATION PER JESD 95-1, SPP-010.
- 4. @ REPRESENTS THE SOLDER BALL GRID PITCH.
- 5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.

SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.

 $\ensuremath{\mathsf{n}}$ IS THE NUMBER OF POPULTED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

Ó DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.

SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.

WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.

WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE = $\boxed{e/2}$

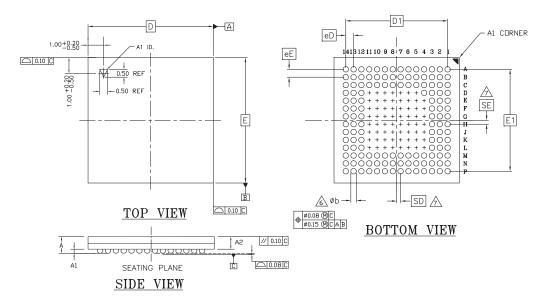
- 8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
- 9. N/A

A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

3436 \ 16-039.22 \ 12.09.04



6.2 NSC133—133-ball Fine-Pitch Ball Grid Array (FBGA) 8.0 x 8.0 mm



PACKAGE		NSC 133		
JEDEC		N/A		
DxE	8.00 mm x 8.00 mm PACKAGE			NOTE
SYMBOL	MIN	NOM	MAX	
Α	0.90	1.00	1.10	PROFILE
A1	0.20	0.25	0.30	BALL HEIGHT
A2	0.70	0.76	0.82	BODY THICKNESS
D		8.00 BSC		BODY SIZE
Е	8.00 BSC			BODY SIZE
D1		6.50 BSC.		MATRIX FOOTPRINT
E1		6.50 BSC.		MATRIX FOOTPRINT
MD		14		MATRIX SIZE D DIRECTION
ME		14		MATRIX SIZE E DIRECTION
n		133		BALL COUNT
Øb	0.25	0.30	0.35	BALL DIAMETER
eЕ	0.50 BSC.			BALL PITCH
eD	0.50 BSC			BALL PITCH
SD/SE	0.25 BSC.			SOLDER BALL PLACEMENT
		4-E11,F4-F1 J4-J11.K4-K1		DEPOPULATED SOLDER BALLS

NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JESD 95-1
- e REPRESENTS THE SOLDER BALL GRID PITCH.
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.

SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.

 $\ensuremath{\text{n}}$ IS THE NUMBER OF POPULTED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.



6 DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.



SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.

WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.

WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE = $\boxed{6/2}$

"+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

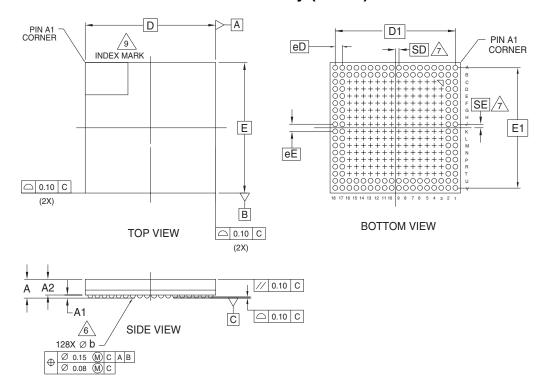


A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

3583 \ 16-039.22 \ 8.15.06



6.3 ALJ128—128-ball Fine-Pitch Ball Grid Array (FBGA) 12.0 x 12.0 mm



PACKAGE		ALJ 128		
JEDEC	N/A			
DxE	12.0	0 mm x 12.00 PACKAGE	0 mm	
SYMBOL	MIN	NOM	MAX	NOTE
Α			1.15	PROFILE
A1	0.35			BALL HEIGHT
A2	0.60		0.72	BODY THICKNESS
D		12.00 BSC.		BODY SIZE
Е		12.00 BSC.		BODY SIZE
D1		11.05 BSC.		MATRIX FOOTPRINT
E1	11.05 BSC.			MATRIX FOOTPRINT
MD		18		MATRIX SIZE D DIRECTION
ME		18		MATRIX SIZE E DIRECTION
n		128		BALL COUNT
N		128		MAXIMUM NUMBER OF BALLS
R		. 2		NUMBER OF LAND PERIMETERS
Øb	0.40	0.45	0.50	BALL DIAMETER
eЕ		0.65 BSC.		BALL PITCH
eD	0.65 BSC			BALL PITCH
SE / SD	0.325 BSC.			SOLDER BALL PLACEMENT
	C3-C16, D3-D16, E3-E16, F3-F16 G3-G16, H3-H16, J3-J16, K3-K16 L3-L16, M3-M16, N3-N16, P3-P16 R3-R16, T3-T16			DEPOPULATED SOLDER BALLS

NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JEP95, SECTION 3.0, SPP-010.
- 4. e REPRESENTS THE SOLDER BALL GRID PITCH.
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.

SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.

 $\ensuremath{\mathsf{n}}$ IS THE NUMBER OF POPULTED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

N IS THE MAXIMUM NUMBER OF BALLS ON THE FBGA PACKAGE.

6 DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.

 $\ensuremath{\mathsf{DATUM}}$ C is the seating plane and is defined by the crowns of the solder balls.

SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.

WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.

WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE = $\boxed{e/2}$

8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

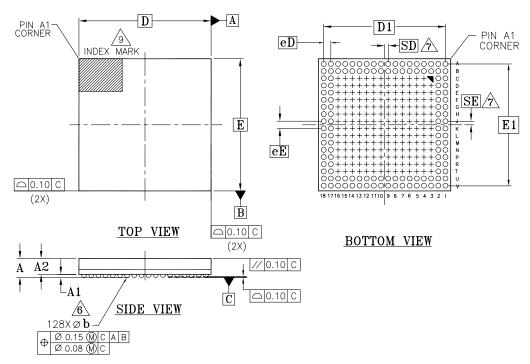
A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.

10 OUTLINE AND DIMENSIONS PER CUSTOMER REQUIREMENT.

2561 16 020 24 \ 5 15 6



6.4 ASF128—128-ball Fine-Pitch Ball Grid Array (FBGA) 12.0 x 12.0 mm



PACKAGE		ASF128		
JEDEC		N/A		
DxE	12.00 mm x 12.00 mm PACKAGE			
SYMBOL	MIN	NOM	MAX	NOTE
Α	0.95	1.05	1.15	PROFILE
A1	0.35	0.40	0.45	BALL HEIGHT
A2	0.59		0.72	BODY THICKNESS
D		12.00 BSC.		BODY SIZE
Е		12.00 BSC.		BODY SIZE
D1	11.05 BSC.			MATRIX FOOTPRINT
E1	11.05 BSC.			MATRIX FOOTPRINT
MD	18			MATRIX SIZE D DIRECTION
ME		18		MATRIX SIZE E DIRECTION
n		128		BALL COUNT
N		128		MAXIMUM NUMBER OF BALLS
R		. 2		NUMBER OF LAND PERIMETERS
Øb	0.40	0.45	0.50	BALL DIAMETER
eЕ	0.65 BSC.			BALL PITCH
eD	0.65 BSC			BALL PITCH
SE / SD	0.325 BSC.			SOLDER BALL PLACEMENT
	F3-F1 J3-J1 M3-M	16,D3-D16,E3 6,G3-G16,H3 16,K3-K16,L3 16,N3-N16,P3 33-R16,T3-T1	3-H16, 3-L16, 3-P16,	DEPOPULATED SOLDER BALLS

NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994.
- 2. ALL DIMENSIONS ARE IN MILLIMETERS.
- BALL POSITION DESIGNATION PER JEP95, SECTION 3.0, SPP-010.
- 4. e REPRESENTS THE SOLDER BALL GRID PITCH.
- 5. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.

SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION.

n IS THE NUMBER OF POPULTED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.

N IS THE MAXIMUM NUMBER OF BALLS ON THE FBGA PACKAGE.

DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL
DIAMETER IN A PLANE PARALLEL TO DATUM C.

DATUM C IS THE SEATING PLANE AND IS DEFINED BY THE CROWNS OF THE SOLDER BALLS.

SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.

WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW SD OR SE = 0.000.

WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE = $\boxed{e/2}$

- 8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.
- 9 A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK, METALLIZED MARK INDENTATION OR OTHER MEANS.
- 10 OUTLINE AND DIMENSIONS PER CUSTOMER REQUIREMENT.

3581\16-039.24\8.3.6



7. Revision History

7.1 Revision 01 (September 6, 2006)

Initial release.

Colophon

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